


Search Notes 	Application/Control No. 10541784	Applicant(s)/Patent Under Reexamination AUFFRET, ERIC
	Examiner Nguyen, Hai V	Art Unit 2618

SEARCHED			
Class	Subclass	Date	Examiner
455	522	02/19/2008	HN

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) (See search history printout report)	02/19/2008	HN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner